

Search Notes

Application/Control No.

10/697,236

Examiner

Mark A. Chapman

Applicant(s)/Patent under
Reexamination

MIKURIYA ET AL.

Art Unit

1756

SEARCHED

Class	Subclass	Date	Examiner
430	108.2	5/27/2005	MC
	108.8		
	109.1		
	109.4		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east	5/27/2005	MC